

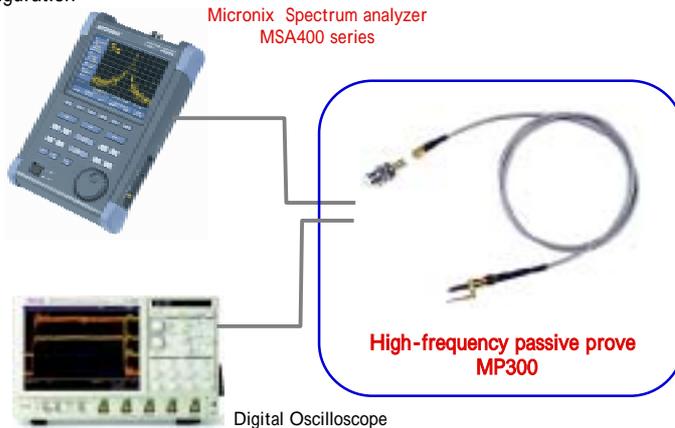
Optimum tool for analysis of high-frequency circuit design (High-frequency passive probe MP300)

[~ *Application* ~]

MP300 is a passive probe that has a wide frequency range and low input capacitance. It is used in connected with measurement equipment (Spectrum analyzer or Oscilloscope). Damping ratio is 10:1 for that MP300's input resistance is 500 . Its ratio is quite lower than popular passive probe and FET probe. Operator is demanded a little attention when measure the circuit in low frequency range (DC-XXXKHz) However, since this probe is low input capacitance and low impedance, it has favourable frequency response in high frequency range. It is useful for analysis and diagnostics on high-frequency circuit design.

[~ *Solution* ~]

Configuration

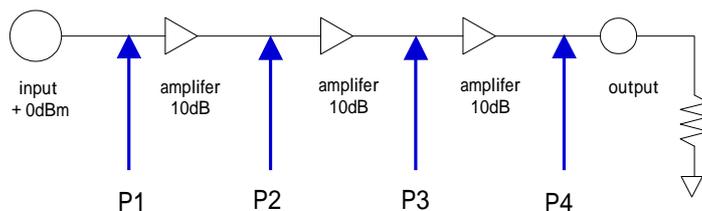


	Specification
frequency bandwidth (-3dB)	6GHz
attenuation ratio	10:1 ± 2% (50 ± 1% connected load)
input resistance	500 ± 2% (50 ± 1% connected load)
input capability	0.25pF (typ)
cable length	1m
connector shape	SMA
input voltage endurance	10Vrms, 20Vpeak (PW<1ms)
operating temperature range	5 ~ 35
operating humidity range	85%RH以下 (non condensing)
storage temperature range	-20 ~ 70

プローブ比較表

price		input impedance		output impedance	measurement frequency range (roughly)	recital
		R	C			
1万円程度	Oscillo probe (10:1)	10M	10pF	9M	DC ~ 200MHz	Adjusting phase of the probe is required
30 ~ 50万円程度	FET Probe	1M	1 ~ 4pF	50	DC ~ 1000MHz	DC power supply is required
99,800円	MP300	500	0.25pF	50	100MHz ~ 6GHz	input impedance is a little lower

Fig of simple circuit component



Suit for comparison of simulation results and failure analysis on design of high-frequency.

() Indicate is 20dB lower than a given level by using 50 line measuring equipment for that probe input impedance is 500Ω.

If this circuit is inputted 0dBm. Since there are three 10dB amplifiers on it, implicit output level is +30dBm. When 50Ω lines Measuring equipment doesn't indicate +10 dBm on output point, there is a defect on this circuit. Measuring each point (P1,P2,P3,P4,) by using this probe that can calculate where circuit defect arise.

※20 log 50 / 500